## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination WU ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,740,152 B1	05-2004	Fukuda, Yuzuru	106/31.72
	В	US-2003/0236321 A1	12-2003	Sano et al.	523/160
	С	US-3,891,487 A	06-1975	Hoey, Charles E.	156/78
	D	US-6,680,089 B2	01-2004	Miyake et al.	428/32.8
	Е	US-		·	
	F	US-			
	G	US-			
	н	US-			
	l	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date . MM-YYYY	Country	Name	Classification .
	N					
	0					
	Р					
	œ			-		
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.